

TEST REPORT

EMC Test for SM-S721B/DS

APPLICANT SAMSUNG Electronics Co., Ltd.

REPORT NO. HCT-EM-2407-FC003

DATE OF ISSUE July 24, 2024

> Tested by Wook Yi

Technical Manager Jeong-Hyun Choi

36

HCT CO., LTD. BongJai Huh



HCT Co., Ltd.

2-6, 73, 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383 KOREA Tel. +82 31 645 6300 Fax. +82 31 645 6401

TEST REPORT

FCC Certification

REPORT NO.

HCT-EM-2407-FC003

DATE OF ISSUE

July 24, 2024

FCC ID.

A3LSMS721B

Applicant	SAMSUNG Electronics Co., Ltd.
	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do,
	16677, Korea
Product Name	Mobile Phone
Model Name	SM-S721B/DS
Series Model Name	SM-S721B
Date of Test	06.20.2024 - 07.22.2024
Location of Test	✓ Permanent Testing Lab ☐ On Site Testing Lab(Address: See clause 1.2)
Test Standard Used	FCC CFR 47 PART 15 Subpart B Class B
	ANSI C63.4-2014
Test Results	Refer to the present document
Manufacturer	SAMSUNG Electronics Co., Ltd.

F-TP22-03 (Rev. 06) Page 2 of 29



REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	July 24, 2024	Initial Release

Notice

Content

The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated.

The test results have only been applied with the test methods required by the standard(s).

The laboratory is not accredited for the test results marked *.

Information provided by the applicant is marked **.

Test results provided by external providers are marked ***.

When confirmation of authenticity of this test report is required, please contact www.hct.co.kr

The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

F-TP22-03 (Rev. 06) Page 3 of 29



CONTENTS

1. TESTING LABORATORY	5
1.1 General Information	5
1.2 Location of the Test Site	5
2. GENERAL INFORMATION	6
2.1 Description of EUT	6
2.2 Power Source	6
2.3 Tested System Details	7
2.4 Cable Description	7
2.5 Noise Suppression Parts on Cable (I/O Cable)	7
2.6 Test Facility	8
2.7 Calibration of Measuring Instrument	8
2.8 Measurement Uncertainty	8
3. DESCRIPTION OF TESTING	9
3.1 Measurement of Conducted Emission	9
3.2 Measurement of Radiated Emission	10
3.3 Configuration of Tested System	12
4. OPERATION OF THE EUT	13
5. MEASURING INSTRUMENT	15
6. EMISSION TEST SUMMARY	17
6.1 Conducted Emission	17
6.2 Radiated Emission Below 1 에z	19
6.3 Radiated Emission Above 1 础	24
7. APPENDIX A. TEST SETUP PHOTO	29

F-TP22-03 (Rev. 06) Page 4 of 29



1. TESTING LABORATORY

1.1 General Information

Organization Name	HCT Co., Ltd.
Address	74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do,
Address	17383. Rep. of Korea
Telephone	+82 31 645 6300
FAX	+82 31 645 6401

1.2 Location of the Test Site

The test site is located at the following address.;

Address	74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do,
	17383. Rep. of Korea
Telephone	+82 31 645 6300
FAX	+82 31 645 6401

F-TP22-03 (Rev. 06) Page 5 of 29



2. GENERAL INFORMATION

2.1 Description of EUT

-	
FCC ID	A3LSMS721B
Product Name	Mobile Phone
Model Name	SM-S721B/DS
Series Model Name	SM-S721B
	GSM 850/900/18001900,
	WCDMA B1/2/4/5/8
Operating	LTE FDD 1/2/3/4/5/7/8/12/13/17/18/19/20/25/26/28/66
Frequency Band	LTE TDD 38/40/41
	5G FR1 n1/2/3/5/7/8/12/20/25/26/28/38/40/41/66/77/78
	BT BDR/EDR/LE, WLAN a/b/g/n/ac/ax, GNSS, NFC
	GSM 850/1900, WCDMA B2/4/5,
Testing	LTE B2/4/5/12/13/17/25/26/41/66,
Frequency Band	5G NR n2/5/25/41/66/77,
	BT BDR/EDR/LE, WLAN a/b/g/n/ac/ax, GNSS, NFC
Manufacturer	SAMSUNG Electronics Co., Ltd.

2.2 Power Source

During the test, the following power supply levels are utilized/provided.;

Power supply: AC 120 V, 60 Hz

F-TP22-03 (Rev. 06) Page 6 of 29



2.3 Tested System Details

All equipment descriptions used in the tested system (including inserted cards) are:

Device Type	Model Name	Serial Number	Manufacturer
Mobile Phone	SM-S721B/DS	SM-S721B/DS - SAI	
Travel Adapter ^{a)}	EP-TA800	-	SOLUM
Data Cable	EP-DN980	-	RFTECH
Earphone	EO-IC100	-	ALMUS

a) Input: 100~240 V, 50~60 Hz, 0.7 A / Output: (PDO)5.0 V, 3.0 A or 9.0 V, 2.77 A (PPS)3.3~5.9 V, 3.0 A or 3.3~11.0 V, 2.25 A

2.4 Cable Description

Product Name	Port	Power Cord Shielded (Y/N)	I/O Cable Shielded (Y/N)	Length (m)
	USB Type C (Data Cable)	Υ	N/A	(P) 1.0
EUT	USB Type C (Earphone)	N/A	N	(D) 1.3

[&]quot;(D)" data cable and "(P)" power cable

2.5 Noise Suppression Parts on Cable (I/O Cable)

Product Name	Port		Location	Metal Hood (Y/N)	Location
	Data Cable (USB Type C)	N	N/A	Υ	Both End
EUT	Earphone (USB Type C)	N	N/A	Υ	EUT End

F-TP22-03 (Rev. 06) Page 7 of 29



2.6 Test Facility

The measurement facilities are constructed in conformance with the requirements of ANSI C63.4-2014. The Normalized site attenuations (30 MHz to 1 GHz) and Site validation (1 GHz to 18 GHz) were performed in accordance with the standard in ANSI C63.4-2014 and ANSI C63.4a-2017

Our laboratories are accredited and designated in accordance with the provisions of Radio Waves ACT and International Standard ISO/IEC 17025:2017. (National Radio Research Agency, CABID No. KR0032)

2.7 Calibration of Measuring Instrument

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturers recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5:2017.

2.8 Measurement Uncertainty

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of k = 2 to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Test Site	Expanded Uncertainty		
Conducted Emission	EMI Shield Room	1.5 dB		
		30 MHz to 1 GHz: 5.8 dB 1 GHz to 18 GHz: 4.9 dB		
Radiated Emission	3 m Semi Anechoic Chamber #1			
		18 GHz to 40 GHz: 5.9 dB		

F-TP22-03 (Rev. 06) Page 8 of 29



3. DESCRIPTION OF TESTING

3.1 Measurement of Conducted Emission

The test procedure was in accordance with ANSI C63.4-2014, Clause 7.3

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN).
 - If the EUT is connected to the PC through USB, the AC power-line adapter of the PC is directly connected to a line impedance stabilization network (LISN).
 - Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both conducted lines are measured in Quasi-Peak and Average mode, including the worst-case data points for each tested configuration.
- c. The frequency range from 150 kHz to 30 MHz was searched.

Conducted Emission Limits

Francis mark	Resolution	Class A		Class B	
Frequency (MHz)	Bandwidth (세z)	Quasi-Peak (dBμV)	Average (dBμV)	Quasi-Peak (dBμV)	Average (dBμV)
0.15 to 0.5	9	79	66	66 to 56*	56 to 46*
0.5 to 5	9	73	60	56	46
5 to 30	9	73	60	60	50

NOTE. Decreases with the logarithm of the frequency.

F-TP22-03 (Rev. 06) Page 9 of 29



3.2 Measurement of Radiated Emission

The test procedure was in accordance with ANSI C63.4-2014, Clause 8.3

- a. The EUT was placed on the top of a turn table 0.8 meters above the ground at a semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 m away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna height is varied from 1 m to 4 m above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 m to 4 m and the turn table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Quasi-Peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 $\,$ GHz.
- f. The test-receiver system was set to Peak and Average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 $\,$ GHz.
- g. Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response.

 (1 GHz to 40 GHz)

Radiated Emission Limits

		Class A		Class B		
Frequency (附z)	Antenna Distance (m)	Field Strength (µV/m)	Quasi-Peak (dBμV/m)	Antenna Distance (m)	Field Strength (µV/m)	Quasi-Peak (dΒμV/m)
30 to 88	10	90	39.0	3	100	40.0
88 to 216	10	150	43.5	3	150	43.5
216 to 960	10	210	46.4	3	200	46.0
Above 960	10	300	49.5	3	500	54.0
_			Class A		Class B	
Frequency (Mlz)	Antenna D (m		Peak (dBμV/m)	Average (dBμV/m)	Peak (dBμV/m)	Average (dBμV/m)
Above 1 000	3		80	60	74	54

F-TP22-03 (Rev. 06) Page 10 of 29



Frequency Range of Radiated Measurements

An unintentional radiator, including a digital device, the spectrum shall be investigated from the lowest radio frequency signal generated or used in the device, without going below the lowest frequency for which a Radiated Emission limit is specified, up to the frequency shown in the following table

Highest frequency generated or used in the device or on which the device operates or tunes (地)	Upper frequency of measurement range (附)
Below 1.705	30
1.705 to 108	1 000
108 to 500	2 000
500 to 1 000	5 000
Above 1 000	5th harmonic of the highest frequency or 40 砧, whichever is lower

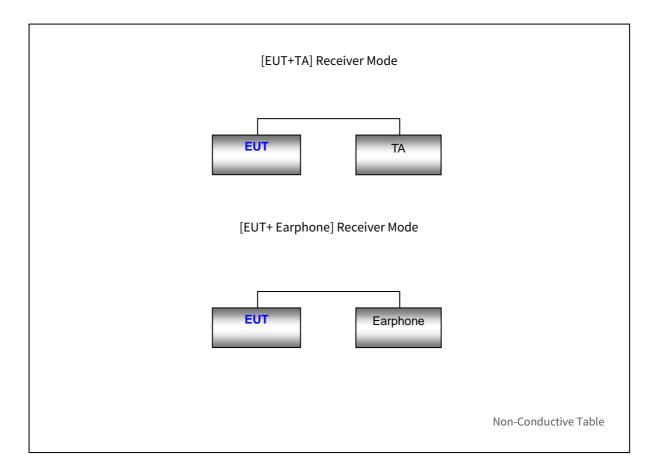
F-TP22-03 (Rev. 06) Page 11 of 29



3.3 Configuration of Tested System

The EUT was configured in the following manner.

At the request of the manufacturer, the configuration of the tests was arranged.



F-TP22-03 (Rev. 06) Page 12 of 29



4. OPERATION OF THE EUT

During preliminary tests, the following operating mode was investigated.

Receiver mode(GSM 850 Low/Middle/High ch Idle)

Receiver mode(WCDMA B5 Low/Middle/High ch Idle)

Receiver mode(LTE B5_Low/Middle/High ch)

Receiver mode(LTE B12_Low/Middle/High ch)

Receiver mode(LTE B13_Low/Middle/High ch)

Receiver mode(LTE B17_Low/Middle/High ch)

Receiver mode(LTE B26_Low/Middle/High ch)

Receiver mode(5G NR n5_Low/Middle/High ch)

NOTE. The worst case is tested.

4.1 Conducted Emission

Operating Mode: LTE B12(B17)+B13 Low ch Idle

NOTE. The worst case of operating mode is reported.

F-TP22-03 (Rev. 06) Page 13 of 29



4.2 Radiated Emission

It was final tested the following operating mode, after connecting all peripheral devices.

Operating Mode:

Radiated Emission below 1 GHz

[EUT+TA] LTE B5+5G NR n5 Low ch Idle

LTE B5+5G NR n5 Middle ch Idle LTE B5+5G NR n5 High ch Idle * LTE B12(B17)+B13 Low ch Idle * LTE B12(B17)+B13 Middle ch Idle LTE B12(B17)+B13 High ch Idle

LTE B26 Low ch Idle LTE B26 Middle ch Idle LTE B26 High ch Idle *

[EUT+ Earphone] LTE B12(B17)+B13 Low ch Idle *

Radiated Emission above 1 础

[EUT+TA] LTE B5+5G NR n5 High ch Idle

LTE B12(B17)+B13 Low ch Idle *

LTE B26 High ch Idle

[EUT+ Earphone] LTE B12(B17)+B13 Low ch Idle *

NOTE.

- 1. Three orientations have been investigated and the worst-case orientation (x-axis: The display of EUT placed on the table is facing upwards) is reported.
- $2. \ \mbox{Frequency}$ bands adjacent to each other are tested as one mode.
- 3. The worst case of operating mode is reported. [*].

F-TP22-03 (Rev. 06) Page 14 of 29



5. MEASURING INSTRUMENT

	Туре	Type Model Name		Serial Number	Calibration Cycle	Next Calibration Date
Cor	nducted emission			1	,	
	EMI Test Receiver	st Receiver ESCI		100584	1 year	05.08.2025
\boxtimes	LISN	ENV216	Rohde & Schwarz	102245	1 year	07.17.2025
\boxtimes	Radio communication analyzer	MT8821C	ANRITSU	6262192376	1 year	10.17.2024
\boxtimes	Antenna (for Communication)	HyperLOG7060	Aaronia	66450	-	-
\boxtimes	Software	EMC32	Rohde & Schwarz	-	-	-
Rac	diated emission below 1	GHz				
\boxtimes	EMI Test Receiver	ESU40	Rohde & Schwarz	100524	1 year	05.07.2025
\boxtimes	Bi-Log Antenna	VULB9168	Schwarzbeck	255	2 year	03.10.2025
\boxtimes	Antenna master	MA4640-XP-ET	INNCO SYSTEM	-	N/A	-
\boxtimes	Antenna master controller	CO3000	INNCO SYSTEM	CO3000/870/ 35990515/L	N/A	-
\boxtimes	Turn Table	1060	INNCO SYSTEM	-	N/A	-
\boxtimes	Turn Table controller	CO2000	INNCO SYSTEM	CO2000/095/ 7590304/L	N/A	-
\boxtimes	Universal radio communication tester	CMU200	Rohde & Schwarz	107488	1 year	09.22.2024
\boxtimes	Mobile communication test set	CMW500	Rohde & Schwarz	103246	1 year	08.28.2024
\boxtimes	Radio communication analyzer	MT8821C	ANRITSU	6262192376	1 year	10.17.2024
	Antenna (for Communication)	HyperLOG7060	Aaronia	66450	-	-
\boxtimes	Radio communication analyzer	MT8000A	ANRITSU	6262208294	1 year	10.17.2024
\boxtimes	Antenna (for Communication)	HyperLOG7060	Aaronia	66451	-	-
\boxtimes	Software	EMC32	Rohde & Schwarz	-	-	-

F-TP22-03 (Rev. 06) Page 15 of 29



Туре		ype Model Name		Serial Number	Calibration Cycle	Next Calibration Date
Rac	liated emission above 1	GHz				
\boxtimes	EMI Test Receiver	ESU40	Rohde & Schwarz	100524	1 year	05.07.2025
\boxtimes	Antenna master	MA4640-XP-ET	INNCO SYSTEM	-	N/A	-
\boxtimes	Antenna master controller	CO3000	INNCO SYSTEM	CO3000/870/ 35990515/L	N/A	-
\boxtimes	Turn Table	1060	INNCO SYSTEM	-	N/A	-
\boxtimes	Turn Table controller	Table controller CO2000		CO2000/095/ 7590304/L	N/A	-
\boxtimes	Low Noise Amplifier	TK-PA18H	TESTEK	170034-L	1 year	11.01.2024
\boxtimes	Low Noise Amplifier	TK-PA1840H	TESTEK	170030-L	1 year	02.20.2025
\boxtimes	Horn Antenna	HF907	Rohde & Schwarz	103160	1 year	10.16.2024
\boxtimes	Horn Antenna	BBHA 9170	Schwarzbeck	BBHA9170 #786	1 year	11.01.2024
\boxtimes	Radio communication analyzer	MT8821C	ANRITSU	6262192376	1 year	10.17.2024
\boxtimes	Mobile communication test set	CMW500	Rohde & Schwarz	103246	1 year	08.28.2024
\boxtimes	Universal radio communication tester	CMU200	Rohde & Schwarz	107488	1 year	09.22.2024
\boxtimes	Antenna (for Communication)	HyperLOG7060	Aaronia	66450	-	-
\boxtimes	Radio communication analyzer	MT8000A	ANRITSU	6262208294	1 year	10.17.2024
\boxtimes	Antenna (for Communication)	HyperLOG7060	Aaronia	66451	-	-
\boxtimes	Software	EMC32	Rohde & Schwarz	-	-	-

F-TP22-03 (Rev. 06) Page 16 of 29



6. EMISSION TEST SUMMARY

6.1 Conducted Emission

6.1.1 Operating Condition

The test results of conducted emission at mains ports provide the following information:

FCC CFR 47 PART 15 Subpart B Class B ANSI C63.4-2014 Frequency Range 150 kHz to 30 MHz Detector Quasi-Peak, CISPR-Average Bandwidth 9 kHz (6 dB) Operating Mode LTE B12(B17)+B13 Low ch Idle Test Site EMI Shield Room Temperature min. 22.3 °C / max. 25.1 °C Relative Humidity min. 41.8 % / max. 44.8 % Test Date 07.22.2024		
Detector Quasi-Peak, CISPR-Average Bandwidth 9 kHz (6 dB) Operating Mode LTE B12(B17)+B13 Low ch Idle Test Site EMI Shield Room Temperature min. 22.3 °C / max. 25.1 °C Relative Humidity min. 41.8 % / max. 44.8 %	Test Standard Used	·
Bandwidth 9 kHz (6 dB) Operating Mode LTE B12(B17)+B13 Low ch Idle Test Site EMI Shield Room Temperature min. 22.3 °C / max. 25.1 °C Relative Humidity min. 41.8 % / max. 44.8 %	Frequency Range	150 kHz to 30 MHz
Operating Mode LTE B12(B17)+B13 Low ch Idle Test Site EMI Shield Room Temperature min. 22.3 °C / max. 25.1 °C Relative Humidity min. 41.8 % / max. 44.8 %	Detector	Quasi-Peak, CISPR-Average
Test Site EMI Shield Room Temperature min. 22.3 °C / max. 25.1 °C Relative Humidity min. 41.8 % / max. 44.8 %	Bandwidth	9 kHz (6 dB)
Temperature min. 22.3 °C / max. 25.1 °C min. 41.8 % / max. 44.8 %	Operating Mode	LTE B12(B17)+B13 Low ch Idle
Relative Humidity min. 41.8 % / max. 44.8 %	Test Site	EMI Shield Room
	Temperature	min. 22.3 °C / max. 25.1 °C
Test Date 07.22.2024	Relative Humidity	min. 41.8 % / max. 44.8 %
	Test Date	07.22.2024

A conducted emission is calculated by the following equation.;

Calculation Formula: A = B + C Where

A: QuasiPeak or CAverage in dBμV

B: Receiver reading in dBμV

C: Corr. in dB (LISN Factor + Cable Loss)

Margin in dB = Limit - QuasiPeak or CAverage

L1 = Live, N = Neutral

The measurements from both Live (L1) and Neutral (N) of the LISN are combined into a single graph.

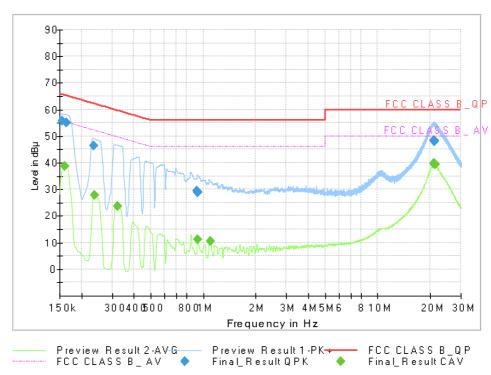
F-TP22-03 (Rev. 06) Page 17 of 29



6.1.2 Measurement Data

LTE B12(B17)+B13 Low ch Idle mode





Frequency (MHz)	QuasiPeak (dBμV)	Limit (dBμV)	Margin (dB)	Bandwidth (kHz)	Line	Corr. (dB)
0.1545	55.57	65.75	10.18	9.000	N	9.5
0.1635	55.16	65.28	10.12	9.000	N	9.5
0.2355	46.28	62.25	15.97	9.000	L1	9.6
0.9208	29.28	56.00	26.72	9.000	N	9.6
0.9253	29.21	56.00	26.79	9.000	N	9.6
0.9298	28.80	56.00	27.20	9.000	N	9.6
20.9098	48.31	60.00	11.69	9.000	L1	9.9
21.0965	48.29	60.00	11.71	9.000	L1	9.9
21.1663	48.16	60.00	11.84	9.000	L1	9.9

Frequency (MHz)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Bandwidth (kHz)	Line	Corr. (dB)
0.1613	38.80	55.40	16.60	9.000	N	9.5
0.2378	27.76	52.17	24.41	9.000	L1	9.6
0.3210	23.66	49.68	26.02	9.000	N	9.5
0.9298	11.12	46.00	34.88	9.000	N	9.6
1.0940	10.54	46.00	35.46	9.000	N	9.6
21.0313	39.54	50.00	10.46	9.000	L1	9.9
21.0538	39.53	50.00	10.47	9.000	L1	9.9
21.1685	39.52	50.00	10.48	9.000	L1	9.9
21.3733	39.38	50.00	10.62	9.000	L1	9.9

F-TP22-03 (Rev. 06) Page 18 of 29



6.2 Radiated Emission Below 1 GHz

6.2.1 Operating Condition

The test results of radiated emission provide the following information:

FCC CFR 47 PART 15 Subpart B Class B ANSI C63.4-2014				
30 MHz to 1 000 MHz				
Quasi-Peak				
120 kHz (6 dB)				
1 m to 4 m				
[EUT+TA]				
LTE B5+5G NR n5 High ch Idle				
LTE B12(B17)+B13 Low ch Idle				
LTE B26 High ch Idle				
[EUT+Earphone]				
LTE B12(B17)+B13 Low ch Idle				
3 m Semi Anechoic Chamber #1				
min. 22.4 °C, max. 26.3 °C				
min. 38.3 %, max. 52.2 %				
06.20.2024 to 07.18.2024				

A field strength is calculated by the following equation.;

Calculation Formula: A = B + C Where

A: Quasi Peak in dBμV/m (Field strength)

B: Receiver reading in $\,dB\mu V$

C: Corr. in dB (Cable loss + Antenna factor)

Margin in dB = Limit - QuasiPeak

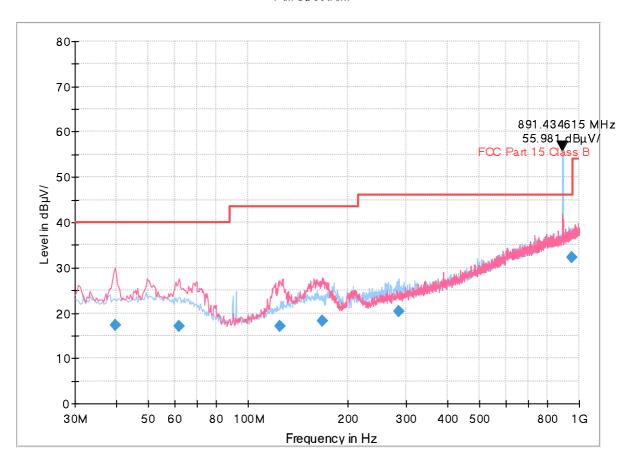
The measurements' polarities are H and V, where H stands for horizontal and V stands for vertical.

F-TP22-03 (Rev. 06) Page 19 of 29



6.2.2 Measurement Data

[EUT+TA] LTE B5+5G NR n5 High ch Idle
Full Spectrum



Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
39.6781	17.32	40.00	22.68	100.0	V	5.0	19.6
61.7535	17.13	40.00	22.87	175.0	V	28.0	19.5
124.4242	17.14	43.50	26.36	125.2	V	148.0	17.8
167.2961	18.18	43.50	25.32	125.2	V	57.0	19.3
285.9666	20.35	46.00	25.65	108.8	Н	218.0	20.1
950.0350	32.22	46.00	13.78	274.8	Н	264.0	32.1

NOTE. 1. Carrier Frequency: Rx 891.4346 Mtz

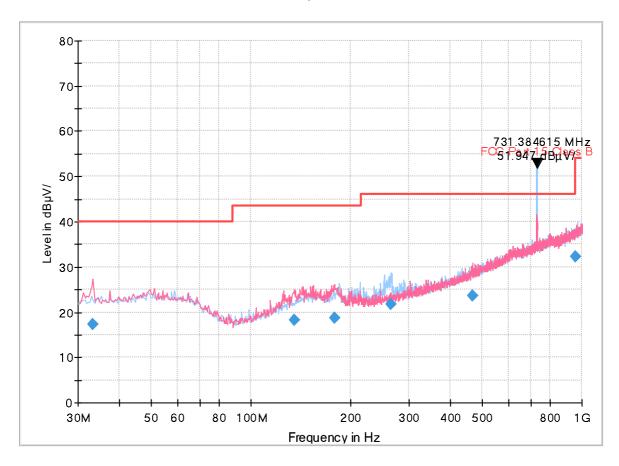
2. These are signals for fundamental frequency from the base station

F-TP22-03 (Rev. 06) Page 20 of 29



[EUT+TA] LTE B12(B17)+B13 Low ch Idle

Full Spectrum



Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
33.3412	17.30	40.00	22.70	110.7	V	176.0	19.0
135.5427	18.25	43.50	25.25	108.9	٧	184.0	19.0
178.8366	18.69	43.50	24.81	100.0	V	319.0	18.4
265.3827	21.72	46.00	24.28	125.2	Н	203.0	19.5
468.7705	23.56	46.00	22.44	183.8	٧	355.0	24.7
956.3532	32.33	46.00	13.67	400.0	Н	56.0	32.2

NOTE. 1. Carrier Frequency: Rx 731.3846 Mtz

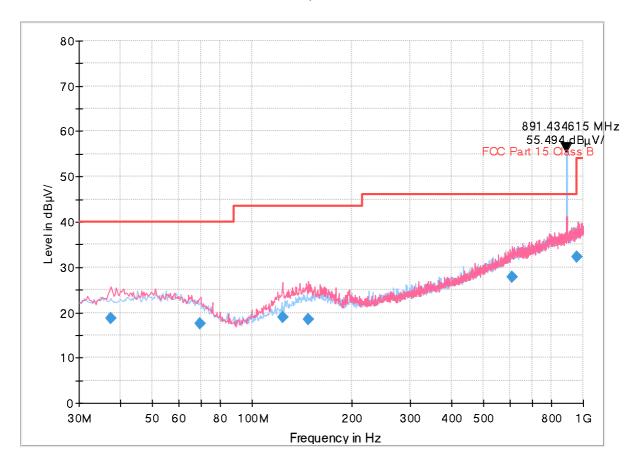
2. These are signals for fundamental frequency from the base station

F-TP22-03 (Rev. 06) Page 21 of 29



[EUT+TA] LTE B26 High ch Idle

Full Spectrum



Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
37.4351	18.68	40.00	21.32	125.2	V	262.0	19.3
69.5558	17.47	40.00	22.53	109.7	V	9.0	18.5
123.6694	18.98	43.50	24.52	125.2	V	175.0	17.7
148.2272	18.52	43.50	24.98	184.7	V	273.0	19.6
612.0276	27.76	46.00	18.24	225.0	V	273.0	27.6
954.4680	32.23	46.00	13.77	184.8	Н	337.0	32.2

NOTE. 1. Carrier Frequency: Rx 891.4346 MHz

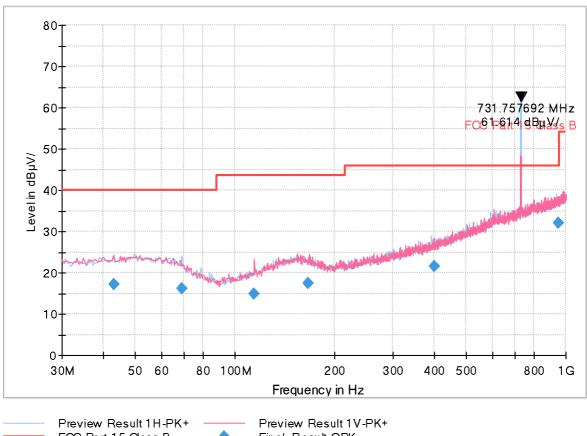
2. These are signals for fundamental frequency from the base station $% \left(1\right) =\left(1\right) \left(1\right$

F-TP22-03 (Rev. 06) Page 22 of 29



[EUT+Earphone] LTE B12(B17)+B13 Low ch Idle

Full Spectrum



Preview Result 1H-PK+	 Preview Result 1V-PK+
FCC Part 15 Class B	Final Result QPK

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
43.0790	17.14	40.00	22.86	110.8	V	88.0	19.8
69.1536	16.20	40.00	23.80	100.0	Н	111.0	18.5
114.3362	14.87	43.50	28.63	274.8	V	190.0	16.8
166.5208	17.48	43.50	26.02	185.8	Н	168.0	19.4
399.7663	21.41	46.00	24.59	100.0	V	122.0	23.1
952.2327	32.17	46.00	13.83	322.7	V	269.0	32.1

NOTE. 1. Carrier Frequency: Rx 731.7576 Mtz

2. These are signals for fundamental frequency from the base station

F-TP22-03 (Rev. 06) Page 23 of 29



6.3 Radiated Emission Above 1 GHz

6.3.1 Operating Condition

The test results of radiated emission provide the following information:

FCC CFD 47 DADT 15 Cubmout D Class D
FCC CFR 47 PART 15 Subpart B Class B
ANSI C63.4-2014
Peak, CISPR-Average
1 MHz
7 125 MHz
1 GHz to 40 GHz
1 m to 4 m
[EUT+TA]
LTE B12(B17)+B13 Low ch Idle
[EUT+Earphone]
LTE B12(B17)+B13 Low ch Idle
3 m Semi Anechoic Chamber #1
min. 22.8 °C, max. 25.3 °C
min. 41.9 %, max. 45.4 %
07.22.2024

A field strength is calculated by the following equation.;

Calculation Formula: A = B + C Where

A: Peak or CAverage in dBμV/m (Field strength)

B: Receiver reading in dBμV

C: Corr. in dB (Cable loss + Antenna factor – Amplifier Gain)

Margin in dB = Limit - Peak or CAverage

The measurements' polarities are H and V, where H stands for horizontal and V stands for vertical.

F-TP22-03 (Rev. 06) Page 24 of 29

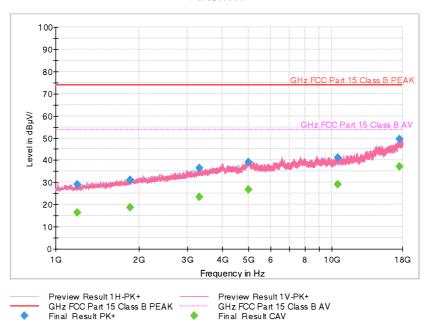


6.3.2 Measurement Data

[EUT+TA] LTE B12(B17)+B13 Low ch Idle

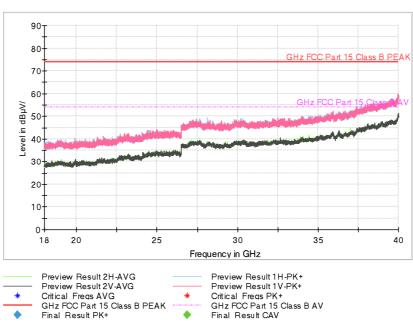
1 GHz to 18 GHz

Full Spectrum



1 GHz to 40 GHz

Full Spectrum



F-TP22-03 (Rev. 06) Page 25 of 29



Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
1200.2450	29.18	74.00	44.82	110.7	Н	173.0	-30.5
1859.0250	31.06	74.00	42.94	183.8	Н	268.0	-26.8
3318.2150	36.39	74.00	37.61	100.0	Н	188.0	-20.3
4977.0500	39.15	74.00	34.85	225.0	V	189.0	-15.0
10469.3100	41.09	74.00	32.91	292.0	Н	322.0	-7.8
17604.0900	49.54	74.00	24.46	174.7	Н	340.0	4.8

Frequency (MHz)	CAverage (dBμV/m)	Limit (dBµV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
1200.2450	16.51	54.00	37.49	110.7	Н	173.0	-30.5
1859.0250	18.80	54.00	35.20	183.8	Н	268.0	-26.8
3318.2150	23.51	54.00	30.49	100.0	Н	188.0	-20.3
4977.0500	26.78	54.00	27.22	225.0	V	189.0	-15.0
10469.3100	29.07	54.00	24.93	292.0	Н	322.0	-7.8
17604.0900	37.12	54.00	16.88	174.7	Н	340.0	4.8

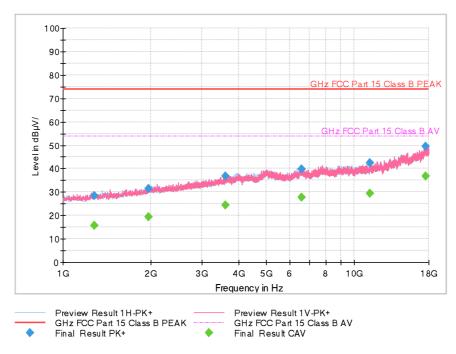
F-TP22-03 (Rev. 06) Page 26 of 29



[EUT+Earphone] LTE B12(B17)+B13 Low ch Idle

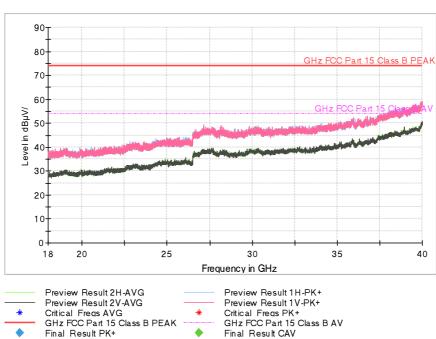
1 GHz to 18 GHz

Full Spectrum



1 GHz to 40 GHz

Full Spectrum



F-TP22-03 (Rev. 06) Page 27 of 29



Final_Result_PK+

Frequency (MHz)	MaxPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
1284.5950	28.54	74.00	45.46	274.7	Н	137.0	-30.1
1969.8500	31.29	74.00	42.71	209.8	V	25.0	-26.1
3602.9700	36.80	74.00	37.20	125.3	V	323.0	-19.2
6587.1650	39.85	74.00	34.15	112.0	V	25.0	-12.1
11269.3750	42.53	74.00	31.47	203.7	V	248.0	-6.2
17599.1150	49.51	74.00	24.49	217.9	Н	0.0	4.8

Final_Result_CAV

Frequency (MHz)	CAverage (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
1284.5950	15.84	54.00	38.16	274.7	Н	137.0	-30.1
1969.8500	19.26	54.00	34.74	209.8	V	25.0	-26.1
3602.9700	24.40	54.00	29.60	125.3	V	323.0	-19.2
6587.1650	27.69	54.00	26.31	112.0	V	25.0	-12.1
11269.3750	29.49	54.00	24.51	203.7	V	248.0	-6.2
17599.1150	36.65	54.00	17.35	217.9	Н	0.0	4.8

F-TP22-03 (Rev. 06) Page 28 of 29



7. APPENDIX A. TEST SETUP PHOTO

Please refer to Appendix. A and test setup photo file no. as follows;

File No.	Date of Issue	Description
HCT-EM-2407-FC003-P	July 24, 2024	Initial Release

End of report

F-TP22-03 (Rev. 06) Page 29 of 29